Application/Control No. Applicant(s)/Patent Under Reexamination BAER ET AL. Examiner HUNG Q PHAM Applicant(s)/Patent Under Reexamination BAER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,959,627	09-1999	Duwaer et al.	345/797
	В	US-			
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NON-PATENT DOCUMENTS

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